Notice of References Cited

Application/Control No. 10/594,932	Applicant(s)/Pater Reexamination ONO, MITSUMAS	
Examiner	Art Unit	
ARMANDO P RAMIREZ	1794	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,580,928 A	12-1996	Doi et al.	525/205
*	В	US-6,503,581 B1	01-2003	Shibue et al.	428/1.1
*	С	US-2004/0190138 A1	09-2004	Toyomasu et al.	359/494
*	D	US-2005/0096431 A1	05-2005	Fujii et al.	525/178
*	Е	US-2005/0128393 A1	06-2005	Yano et al.	349/118
*	F	US-6,964,814 B2	11-2005	Fujii et al.	428/423.1
*	G	US-7,042,540 B2	05-2006	Yano et al.	349/117
*	Н	US-7,466,382 B2	12-2008	Yano et al.	349/118
	Т	US-			
	J	US-			
	к	US-			
	٦	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2002-311241	10-2002	Japan	Minoru et al.	
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON DATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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	U		
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A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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